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| Notice of References Cited | | | Application/Control No. | Applicant(s)/Patent Under Reexamination BARTEK ET AL. | |
| | | | Examiner Nicholas S. Ulrich | Art Unit 2112 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,049,799 A | 04-2000 | Mangat et al. | 707/10 |
| * | B | US-6,256,668 B1 | 07-2001 | Slivka et al. | 709/220 |
| * | C | US-2002/0091993 A1 | 07-2002 | Walley et al. | 717/120 |
| * | D | US-2002/0161876 A1 | 10-2002 | Raymond, Robert | 709/223 |
| * | E | US-2002/0188612 A1 | 12-2002 | Yu et al. | 707/100 |
| * | F | US-2002/0188613 A1 | 12-2002 | Chakraborty et al. | 707/100 |
| * | G | US-2003/0018650 A1 | 01-2003 | Priestley, Michael | 707/102 |
| * | H | US-2003/0059009 A1 | 03-2003 | Meyerson et al. | 379/93.17 |
| * | I | US-6,799,198 B1 | 09-2004 | Huboi et al. | 709/203 |
| * | J | US-6,801,222 B1 | 10-2004 | Dunham et al. | 715/714 |
| * | K | US-2005/0065913 A1 | 03-2005 | Lillie et al. | 707/003 |
| * | L | US-2005/0065953 A1 | 03-2005 | Bower et al. | 707/101 |
| * | M | US-7,024,658 B1 | 04-2006 | Cohen et al. | 717/117 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author; Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | Microsoft, Microsoft Computer Dictionary, 2002, Micorsoft Press, 5th Edition, pg 409 |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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|-----------------------------------|--|--------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination BARTEK ET AL. | |
| | | Examiner Nicholas S. Ulrich | Art Unit 2112 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-5,361,361 A | 11-1994 | Hickman et al. | 715/705 |
| * | B | US-5,893,916 A | 04-1999 | Dooley, Marilyn R. | 715/523 |
| * | C | US-6,011,537 A | 01-2000 | Slotznick, Benjamin | 715/733 |
| * | D | US-6,281,900 B1 | 08-2001 | Ishikawa, Masayuki | 715/853 |
| * | E | US-2002/0054152 A1 | 05-2002 | Palaniappan et al. | 345/810 |
| * | F | US-6,584,496 B1 | 06-2003 | Ludtke, Harold Aaron | 709/217 |
| * | G | US-6,918,090 B2 | 07-2005 | Hesmer et al. | 715/760 |
| * | H | US-6,993,720 B1 | 01-2006 | Hanoch et al. | 715/708 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

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| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | V | |
| | W | |
| | X | |

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.